## Application/Control No. Applicant(s)/Patent Under Reexamination 10/516,786 EDELER ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 **Kiet Doan** 2617 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,961,591 B2 11-2005 Osano, Keiji 455/569.1 08-2002 US-6,430,217 B1 Suzuki et al. В 375/219 \* US-6,203,344 B1 03-2001 С Ito, Akashi 439/218 US-D Ε US-US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Country Name Classification. Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q

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